

Notice of References Cited	Application/Control No. 10/055,490	Applicant(s)/Patent Under Reexamination SEKI ET AL.	
	Examiner Sargon N Nano	Art Unit 2157	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-6,717,913	04-2004	Ghahremani et al.	370/230
	C	US-6,167,445	12-2000	Gai et al.	709/223
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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